Supporting Information

Improving the Efficiency of Polymer Solar Cells Based on

Furan-Flanked Diketopyrrolopyrrole Copolymer via Solvent

Additive and Methanol Treatment

Weilong Zhou,^a Huajie Chen,^b Junjie Lv,^a Youchun Chen,^a Weifeng Zhang,^{b*} Gui Yu^{b*} and Fenghong Li^{a*}

^a State Key Laboratory of Supramolecular Structure and Materials, Institute of Theoretical Chemistry, Jilin University, Changchun, 130012, P. R. China. *E-mail: fhli@jlu.edu.cn.

^b Beijing National Laboratory for Molecular Sciences, Institute of Chemistry, Chinese Academy of Sciences, Beijing 100190, P. R. China. *E-mail: zhangwf@iccas.ac.cn (W. F. Zhang); yugui@iccas.ac.cn (G. Yu).



Figure S1. Current density versus voltage (J-V) characteristics of PDVF-8:PC₇₁BM PSCs from CF+DIO with different concentrations of DIO.

Table S1. Performances of PDVF-8:PC₇₁BM PSCs from CF+DIO with different concentrations of DIO.

Solvents	Jsc [mA cm ⁻²]	Voc [V]	FF [%]	PCE [%]		Rs	Rsh	Rectification
				Max.	Aver.	$[\Omega \text{ cm}^2]$	$[\Omega \text{ cm}^2]$	Ratio
CF+1vol%DIO	8.95	0.650	0.544	3.17	3.12	15.2	785.9	8.3×10^{1}
CF+3vol%DIO	9.73	0.650	0.590	3.73	3.69	7.2	910.6	4.0×10^{2}
CF+5vol%DIO	9.55	0.630	0.577	3.47	3.37	8.4	855.9	4.6×10^{1}
CF+3vol%DIO (MT)	10.30	0.655	0.597	4.03	3.91	7.0	956.1	$6.0 imes 10^{2}$



Figure S2. Current density versus voltage (J–V) characteristics of PDVF-8:PC₇₁BM PSCs from CF+CN with different concentrations of CN.

Table S2. Performances of PDVF-8:PC₇₁BM PSCs from CF+CN with different concentrations of CN.

Solvents	Jsc [mA cm ⁻²]	Voc [V]	FF [%]	PCE [%]		Rs	Rsh	Rectification
				Max.	Aver.	$[\Omega \text{ cm}^2]$	$[\Omega \text{ cm}^2]$	Ratio
CF+1vol%CN	9.46	0.675	0.568	3.63	3.58	12.3	810.8	3.5×10^{2}
CF+3vol%CN	10.89	0.670	0.583	4.26	4.18	7.7	868.7	1.2×10^{3}
CF+5vol%CN	10.20	0.670	0.578	3.95	3.91	7.5	838.2	4.0×10^{2}
CF+3vol%CN (MT)	11.64	0.670	0.601	4.69	4.59	6.2	1083.5	2.2×10^{3}



Figure S3. Current density versus voltage (J-V) characteristics of Device 1-6 in the dark.



Figure S4. $J^{0.5}$ vs. V_{appl} - V_{bi} - V_r plots for the electron-only (a) and the hole-only devices (b) from different solvent/solvent mixture without or with MT.



Figure S5. S2p and C1s XPS spectra of PDVF-8:PC₇₁BM film spin-coated from CF+3vol% CN without (a and b) and with (c and d) MT in different etching time.